



**THE DATASHEET OF
IRG4BC30FD-S**



International IR Rectifier

INSULATED GATE BIPOLAR TRANSISTOR WITH
HYPERFAST DIODE

PD - 95970A

IRG4BC30FD-SPbF

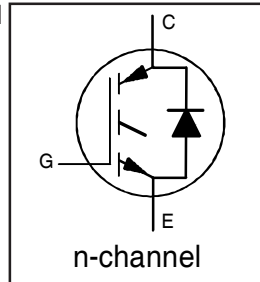
Fast CoPack IGBT

Features

- Fast: optimized for medium operating frequencies (1-5 kHz in hard switching, >20kHz in resonant mode).
- Generation 4 IGBT design provides tighter parameter distribution and higher efficiency than Generation 3.
- IGBT co-packaged with HEXFRED™ ultrafast, ultra-soft recovery anti-parallel diodes for use in bridge configurations.
- Lead-Free

Benefits

- Generation 4 IGBT's offer highest efficiency available.
- IGBT's optimized for specific application conditions.
- HEXFRED diodes optimized for performance with IGBT's. Minimized recovery characteristics require less/no snubbing.
- Designed to be a "drop-in" replacement for equivalent industry-standard Generation 3 IR IGBT's.



$V_{CES} = 600V$
 $V_{CE(on)} \text{ typ.} = 1.59V$
 @ $V_{GE} = 15V, I_C = 17A$



Absolute Maximum Ratings

| | Parameter | Max. | Units |
|---------------------------|-------------------------------------------|-------------|------------|
| V_{CES} | Collector-to-Emitter Voltage | 600 | V |
| $I_C @ T_C = 25^\circ C$ | Continuous Collector Current | 31 | A |
| $I_C @ T_C = 100^\circ C$ | Continuous Collector Current | 17 | |
| I_{CM} | Pulse Collector Current (Ref.Fig.C.T.5) ① | 124 | |
| I_{LM} | Clamped Inductive Load current ② | 124 | |
| $I_F @ T_C = 100^\circ C$ | Diode Continuous Forward Current | 12 | |
| I_{FM} | Diode Maximum Forward Current | 120 | |
| V_{GE} | Gate-to-Emitter Voltage | ± 20 | V |
| $P_D @ T_C = 25^\circ C$ | Maximum Power Dissipation | 100 | W |
| $P_D @ T_C = 100^\circ C$ | Maximum Power Dissipation | 42 | |
| T_J | Operating Junction and | -55 to +150 | $^\circ C$ |
| T_{STG} | Storage Temperature Range | | |

Thermal / Mechanical Characteristics

| | Parameter | Min. | Typ. | Max. | Units |
|-----------------|---------------------------------------------------|------|------------|------|--------------|
| $R_{\theta JC}$ | Junction-to-Case- IGBT | — | — | 1.2 | $^\circ C/W$ |
| $R_{\theta CS}$ | Case-to-Sink, flat, greased surface | — | 0.50 | — | |
| $R_{\theta JA}$ | Junction-to-Ambient (PCB Mounted, steady state) ③ | — | — | 40 | |
| Wt | Weight | — | 2.0 (0.07) | — | g (oz.) |

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Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

| | Parameter | Min. | Typ. | Max. | Units | Conditions |
|----------------------------------------|------------------------------------------|------|------|------|-------|----------------------------------------------------------------------|
| V _{(BR)CES} | Collector-to-Emitter Breakdown Voltage ③ | 600 | — | — | V | V _{GE} = 0V, I _C = 250μA |
| ΔV _{(BR)CES} /ΔT _J | Temperature Coeff. of Breakdown Voltage | — | 0.69 | — | V/°C | V _{GE} = 0V, I _C = 1mA |
| V _{CE(on)} | Collector-to-Emitter Voltage | — | 1.59 | 1.8 | V | I _C = 17A V _{GE} = 15V |
| | | — | 1.99 | — | | I _C = 31A See Fig. 2, 5 |
| | | — | 1.7 | — | | I _C = 17A, T _J = 150°C |
| V _{GE(th)} | Gate Threshold Voltage | 3.0 | — | 6.0 | V | V _{CE} = V _{GE} , I _C = 250μA |
| ΔV _{GE(th)} /ΔT _J | Threshold Voltage temp. coefficient | — | -11 | — | mV/°C | V _{CE} = V _{GE} , I _C = 250μA |
| g _{fe} | Forward Transconductance ④ | 6.1 | 10 | — | S | V _{CE} = 100V, I _C = 17A |
| I _{CES} | Zero Gate Voltage Collector Current | — | — | 250 | μA | V _{GE} = 0V, V _{CE} = 600V |
| | | — | — | 2500 | | V _{GE} = 0V, V _{CE} = 600V, T _J = 150°C |
| V _{FM} | Diode Forward Voltage Drop | — | 1.4 | 1.7 | V | I _F = 12A See Fig. 13 |
| | | — | 1.3 | 1.6 | | I _F = 12A, T _J = 150°C |
| I _{GES} | Gate-to-Emitter Leakage Current | — | — | ±100 | nA | V _{GE} = ±20V |

Switching Characteristics @ T_J = 25°C (unless otherwise specified)

| | Parameter | Min. | Typ. | Max. | Units | Conditions |
|-------------------------|-----------------------------------------------------------|------|------|------|-------|----------------------------------------------------------|
| Q _g | Total Gate Charge (turn-on) | — | 51 | 77 | nC | I _C = 17A |
| Q _{ge} | Gate-to-Emitter Charge (turn-on) | — | 7.9 | 12 | | V _{CC} = 400V See Fig. 8 |
| Q _{gc} | Gate-to-Collector Charge (turn-on) | — | 19 | 28 | | V _{GE} = 15V |
| t _{d(on)} | Turn-On delay time | — | 42 | — | ns | T _J = 25°C |
| t _r | Rise time | — | 26 | — | | I _C = 17A, V _{CC} = 480V |
| t _{d(off)} | Turn-Off delay time | — | 230 | 350 | | V _{GE} = 15V, R _G = 23Ω |
| t _f | Fall time | — | 160 | 230 | | Energy losses include "tail" and diode reverse recovery. |
| E _{on} | Turn-On Switching Loss | — | 0.63 | — | mJ | See Fig. 9, 10, 11, 18 |
| E _{off} | Turn-Off Switching Loss | — | 1.39 | — | | |
| E _{ts} | Total Switching Loss | — | 2.02 | 3.9 | | |
| t _{d(on)} | Turn-On delay time | — | 42 | — | ns | T _J = 150°C See Fig. 9,10,11,18 |
| t _r | Rise time | — | 27 | — | | I _C = 17A, V _{CC} = 480V |
| t _{d(off)} | Turn-Off delay time | — | 310 | — | | V _{GE} = 15V, R _G = 23Ω |
| t _f | Fall time | — | 310 | — | | Energy losses include "tail" and diode reverse recovery. |
| E _{ts} | Total Switching Loss | — | 3.2 | — | mJ | |
| L _E | Internal Emitter Inductance | — | 7.5 | — | nH | Measured 5mm from package |
| C _{ies} | Input Capacitance | — | 1100 | — | pF | V _{GE} = 0V |
| C _{oes} | Output Capacitance | — | 74 | — | | V _{CC} = 30V See Fig. 7 |
| C _{res} | Reverse Transfer Capacitance | — | 14 | — | | f = 1.0MHz |
| t _{rr} | Diode Reverse Recovery Time | — | 42 | 60 | ns | T _J = 25°C See Fig. 14 |
| | | — | 80 | 120 | | T _J = 125°C |
| I _{rr} | Diode Peak Reverse Recovery Current | — | 3.5 | 6.0 | A | T _J = 25°C See Fig. 15 |
| | | — | 5.6 | 10 | | T _J = 125°C |
| Q _{rr} | Diode Reverse Recovery Charge | — | 80 | 180 | nC | T _J = 25°C See Fig. 16 |
| | | — | 220 | 600 | | T _J = 125°C |
| di _(rec) /dt | Diode Peak Rate of Fall of Recovery During t _b | — | 180 | — | A/μs | T _J = 25°C See Fig. 17 |
| | | — | 120 | — | | T _J = 125°C |

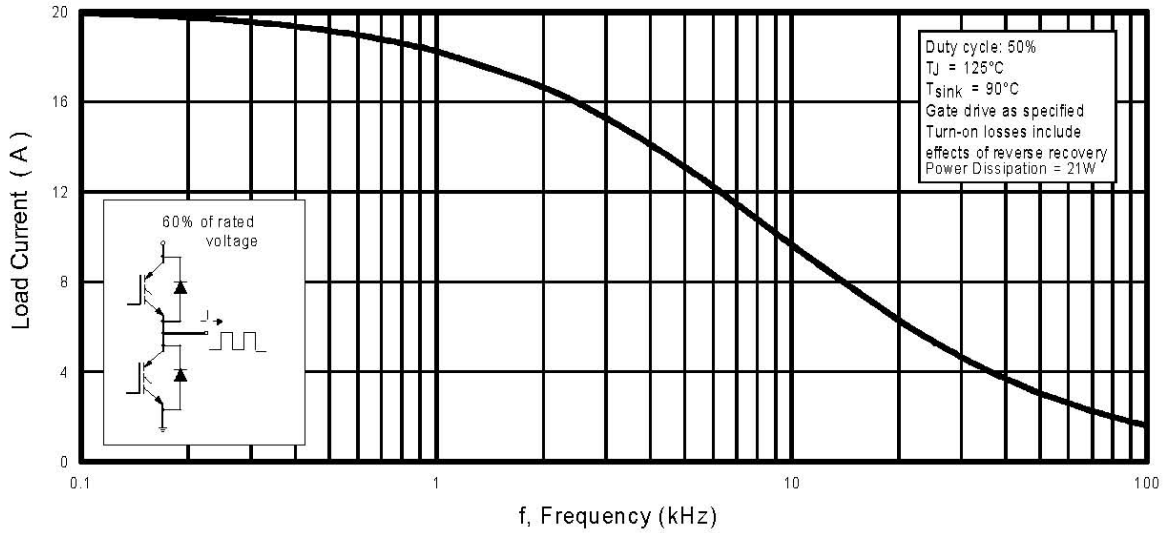


Fig. 1 - Typical Load Current vs. Frequency
 (Load Current = I_{RMS} of fundamental)

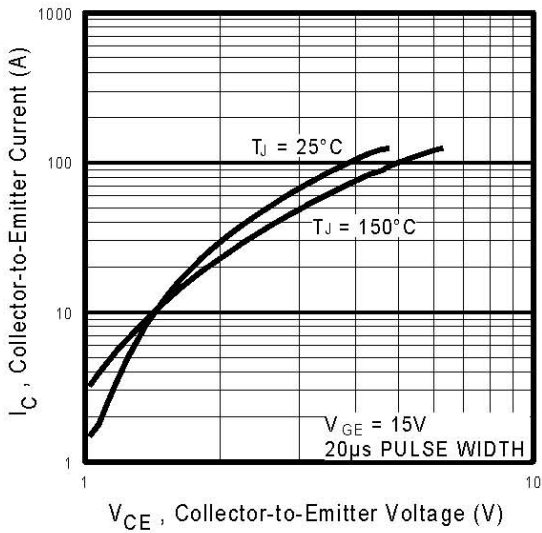


Fig. 2 - Typical Output Characteristics

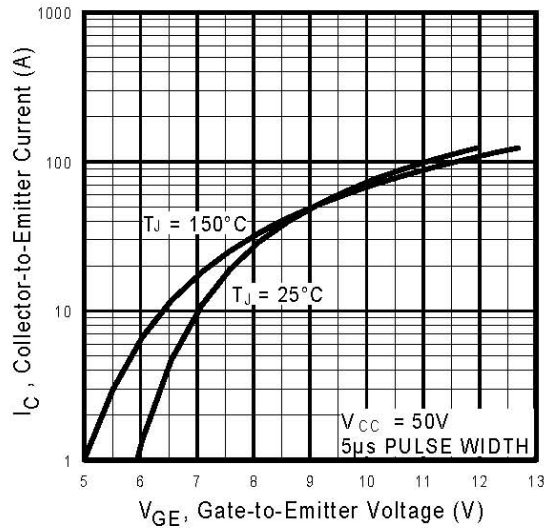


Fig. 3 - Typical Transfer Characteristics

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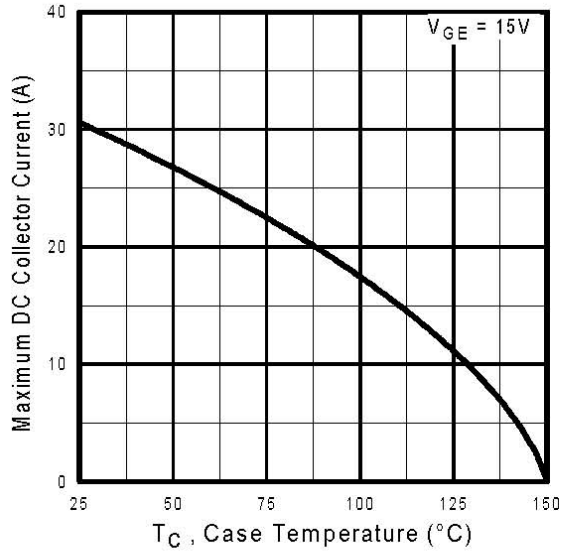


Fig. 4 - Maximum Collector Current vs. Case Temperature

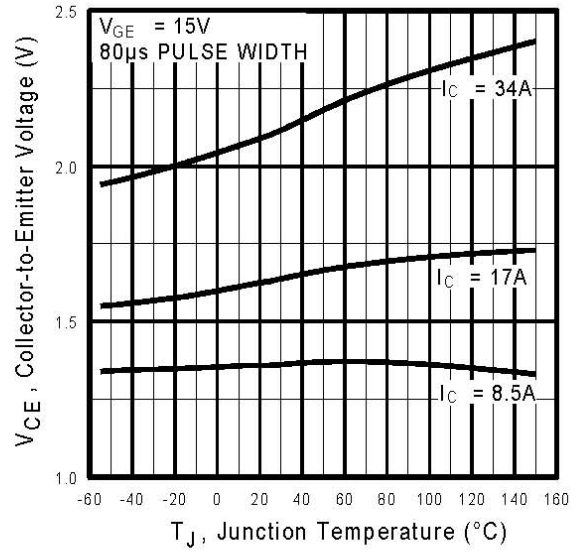


Fig. 5 - Typical Collector-to-Emitter Voltage vs. Junction Temperature

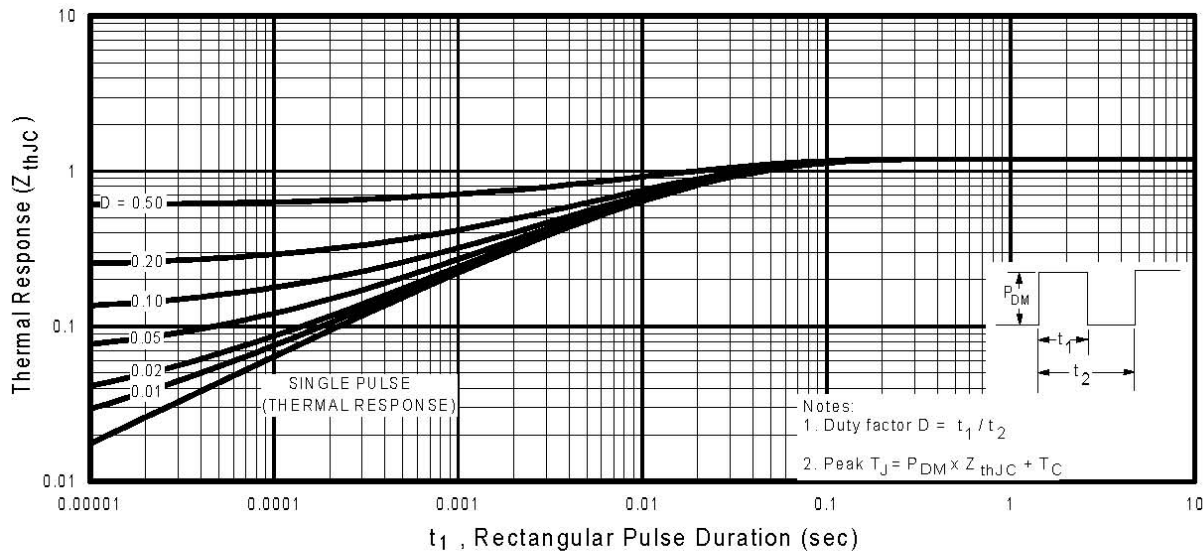


Fig. 6 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

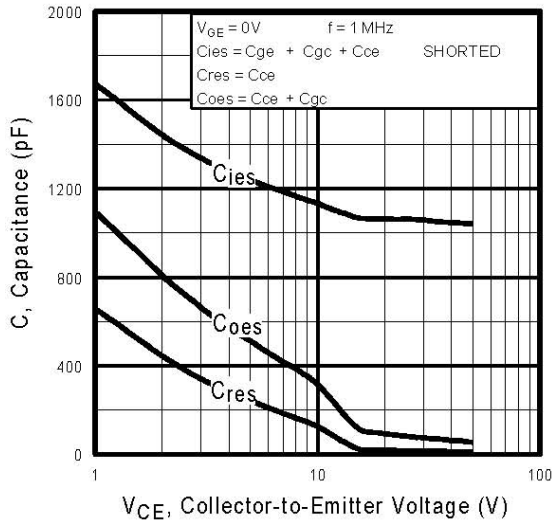


Fig. 7 - Typical Capacitance vs. Collector-to-Emitter Voltage

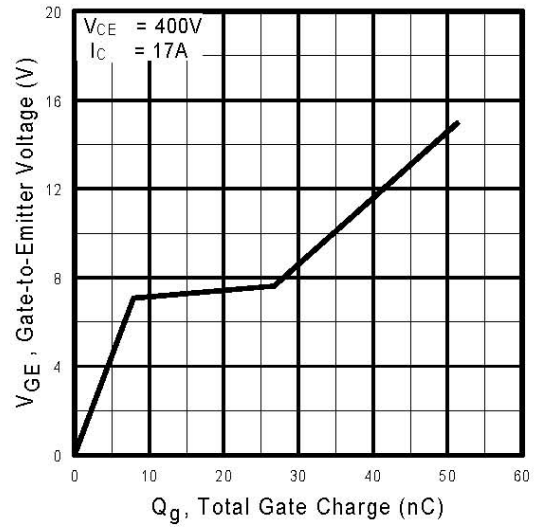


Fig. 8 - Typical Gate Charge vs. Gate-to-Emitter Voltage

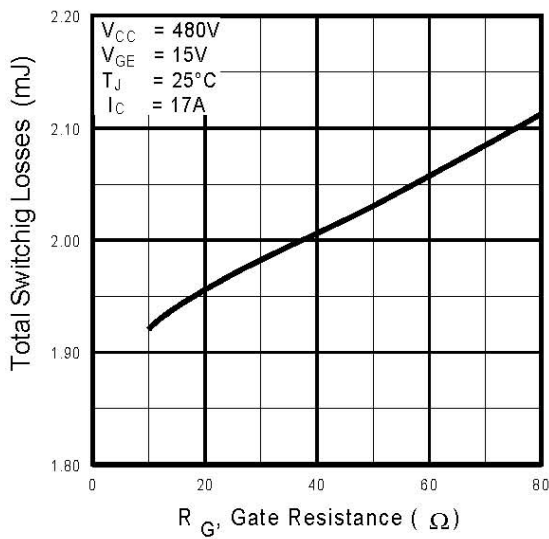


Fig. 9 - Typical Switching Losses vs. Gate Resistance

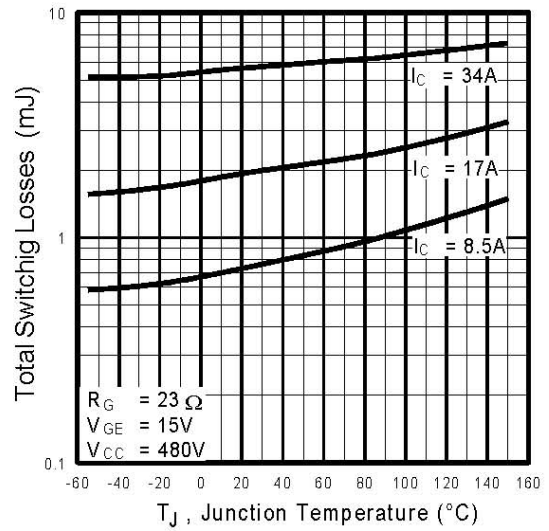


Fig. 10 - Typical Switching Losses vs. Junction Temperature

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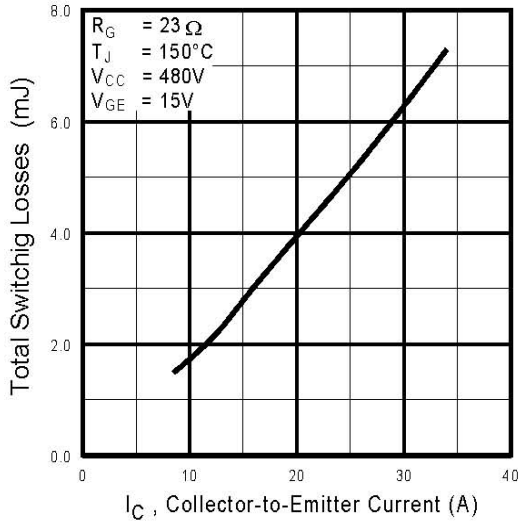


Fig. 11 - Typical Switching Losses vs. Collector-to-Emitter Current

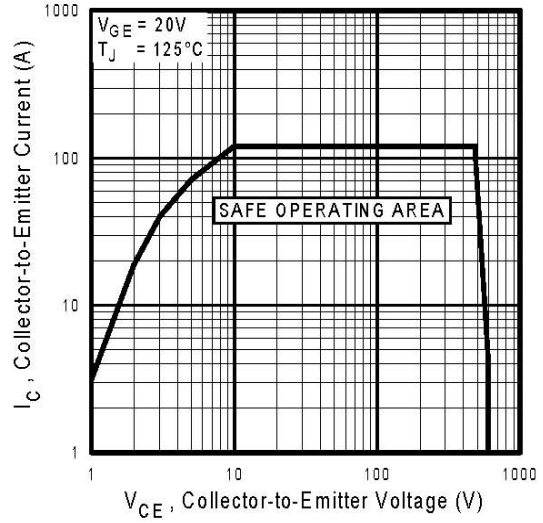


Fig. 12 - Turn-Off SOA

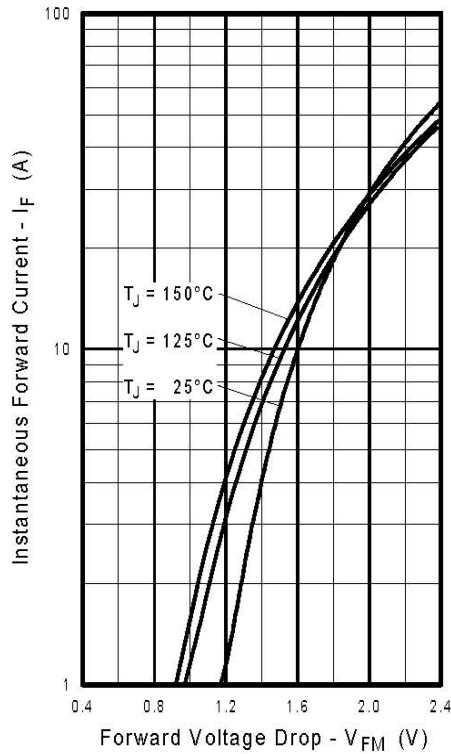


Fig. 13 - Maximum Forward Voltage Drop vs. Instantaneous Forward Current

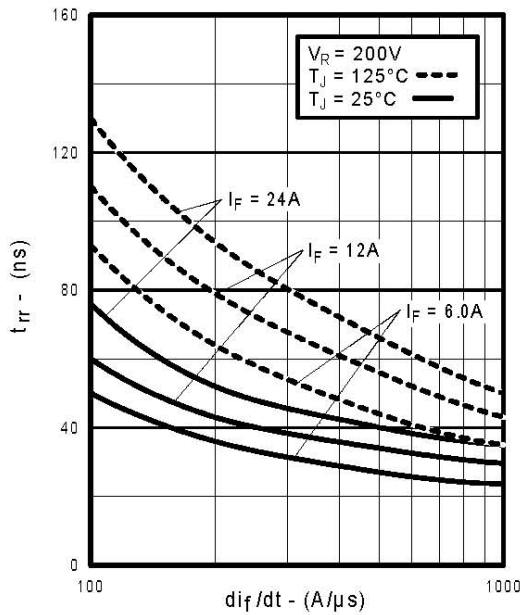


Fig. 14 - Typical Reverse Recovery vs. di_f/dt

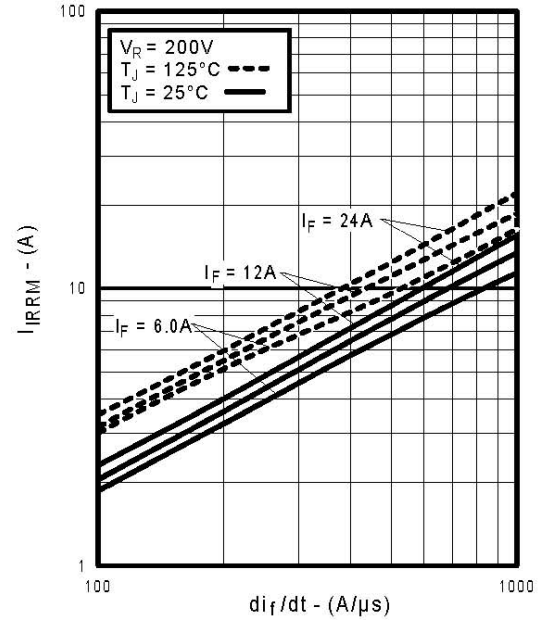


Fig. 15 - Typical Recovery Current vs. di_f/dt

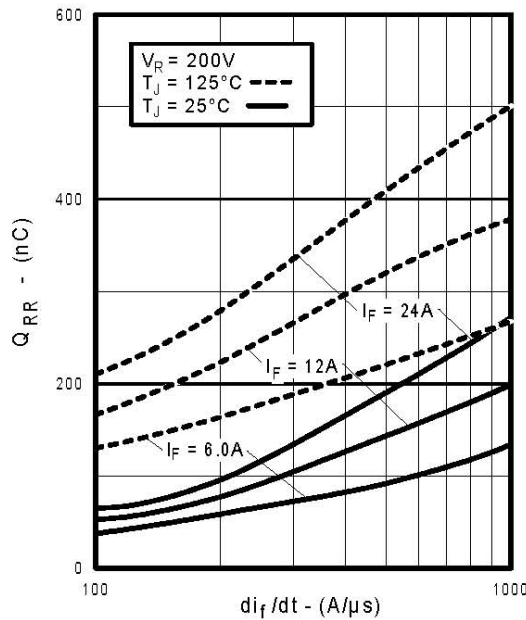


Fig. 16 - Typical Stored Charge vs. di_f/dt

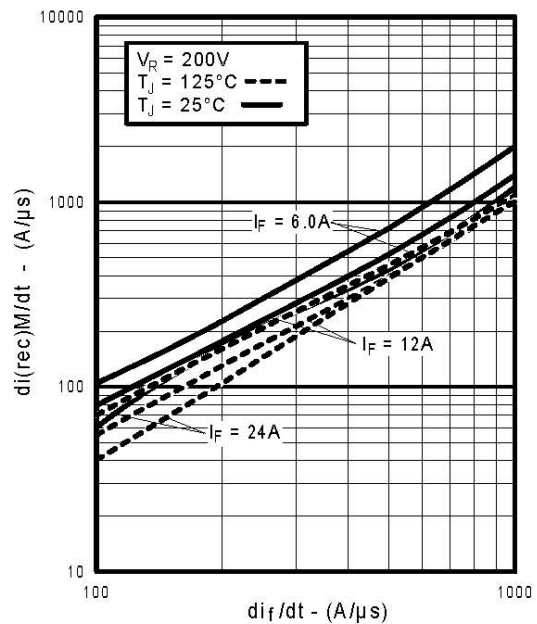


Fig. 17 - Typical $di_{(rec)M}/dt$ vs. di_f/dt

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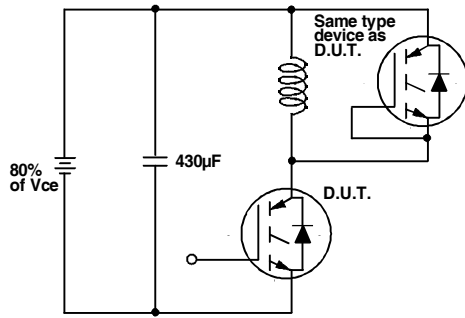


Fig. 18a - Test Circuit for Measurement of I_{LM} , E_{on} , $E_{off}(\text{diode})$, t_{rr} , Q_{rr} , I_{rr} , $t_{d(on)}$, t_r , $t_{d(off)}$, t_f

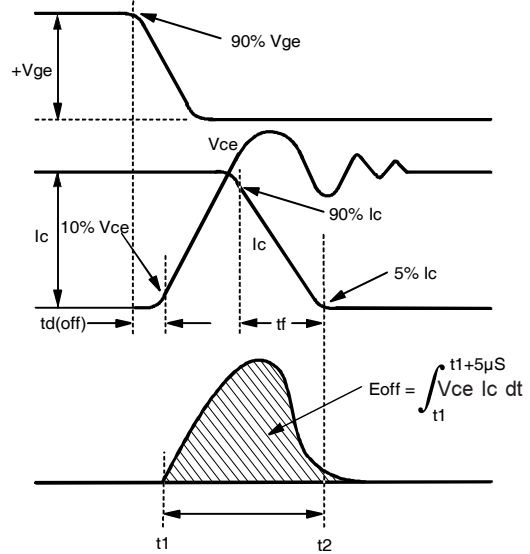


Fig. 18b - Test Waveforms for Circuit of Fig. 18a, Defining E_{off} , $t_{d(off)}$, t_f

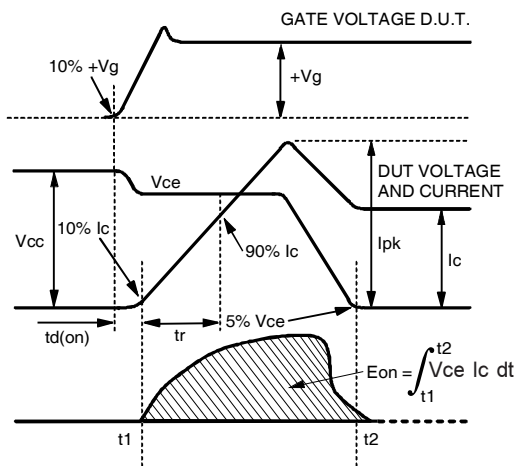


Fig. 18c - Test Waveforms for Circuit of Fig. 18a, Defining E_{on} , $t_{d(on)}$, t_r

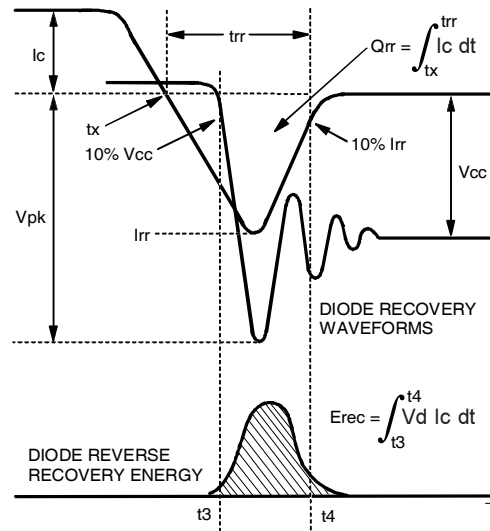


Fig. 18d - Test Waveforms for Circuit of Fig. 18a, Defining E_{rec} , t_{rr} , Q_{rr} , I_{rr}

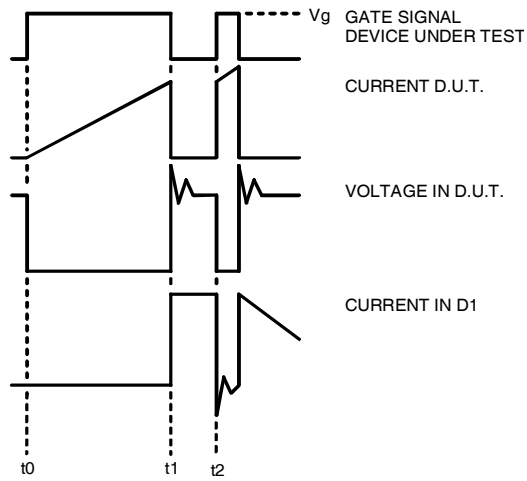


Fig.18e - Macro Waveforms for Figure 18a's Test Circuit

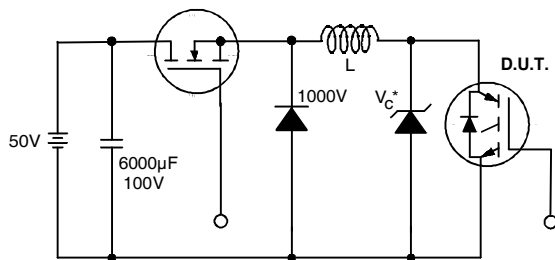
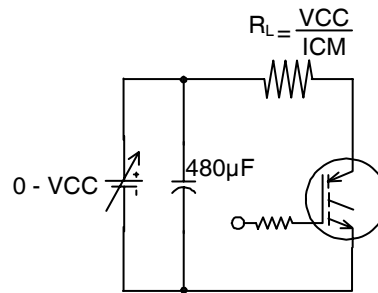


Fig. 19 - Clamped Inductive Load Test Circuit



Pulsed Collector Current
 Test Circuit

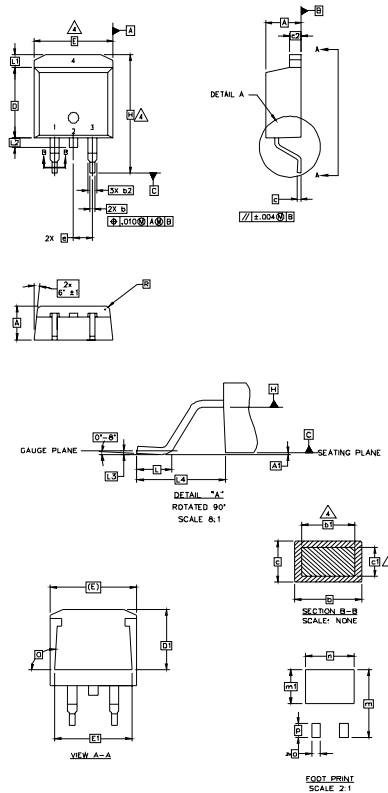
Fig. 20 - Pulsed Collector Current
 Test Circuit

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D²Pak Package Outline

Dimensions are shown in millimeters (inches)



NOTES:

1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994
2. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].
3. DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED 0.127 [0.005"] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY.
4. DIMENSION b1 AND c1 APPLY TO BASE METAL ONLY.
5. CONTROLLING DIMENSION: INCH.

| SYMBOL | DIMENSIONS | | | | NOTES |
|--------|-------------|-------|----------|------|-------|
| | MILLIMETERS | | INCHES | | |
| | MIN. | MAX. | MIN. | MAX. | |
| A | 4.06 | 4.83 | .160 | .190 | |
| A1 | 0.00 | 0.254 | .000 | .010 | |
| b | 0.51 | 0.99 | .020 | .039 | 4 |
| b1 | 0.51 | 0.89 | .020 | .035 | |
| b2 | 1.14 | 1.78 | .045 | .070 | |
| c | 0.38 | 0.74 | .015 | .029 | |
| c1 | 0.38 | 0.58 | .015 | .023 | 4 |
| c2 | 1.14 | 1.65 | .045 | .065 | |
| D | 8.51 | 9.65 | .335 | .380 | 3 |
| D1 | 6.86 | | .270 | | |
| E | 9.65 | 10.67 | .380 | .420 | 3 |
| E1 | 6.22 | | .245 | | |
| e | 2.54 BSC | | .100 BSC | | |
| H | 14.61 | 15.88 | .575 | .625 | |
| L | 1.78 | 2.79 | .070 | .110 | |
| L1 | | 1.65 | .065 | | |
| L2 | 1.27 | 1.78 | .050 | .070 | |
| L3 | 0.25 BSC | | .010 BSC | | |
| L4 | 4.78 | 5.28 | .188 | .208 | |
| m | 17.78 | | .700 | | |
| m1 | 8.89 | | .350 | | |
| n | 11.43 | | .450 | | |
| o | 2.08 | | .082 | | |
| p | 3.81 | | .150 | | |
| R | 0.51 | 0.71 | .020 | .028 | |
| theta | 90° | 93° | 90° | 93° | |

LEAD ASSIGNMENTS

HEXFET

- 1.- GATE
- 2, 4.- DRAIN
- 3.- SOURCE

IGBTs, CoPACK

- 1.- GATE
- 2, 4.- COLLECTOR
- 3.- EMITTER

DIODES

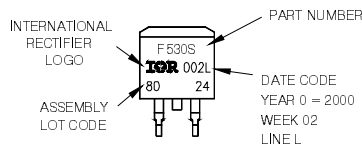
- 1.- ANODE *
- 2, 4.- CATHODE
- 3.- ANODE

* PART DEPENDENT.

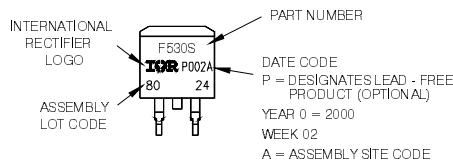
D²Pak Part Marking Information

EXAMPLE: THIS IS AN IRF530S WITH
LOT CODE 8024
ASSEMBLED ON WW 02, 2000
IN THE ASSEMBLY LINE 'L'

Note: "P" in assembly line position
indicates "Lead - Free"



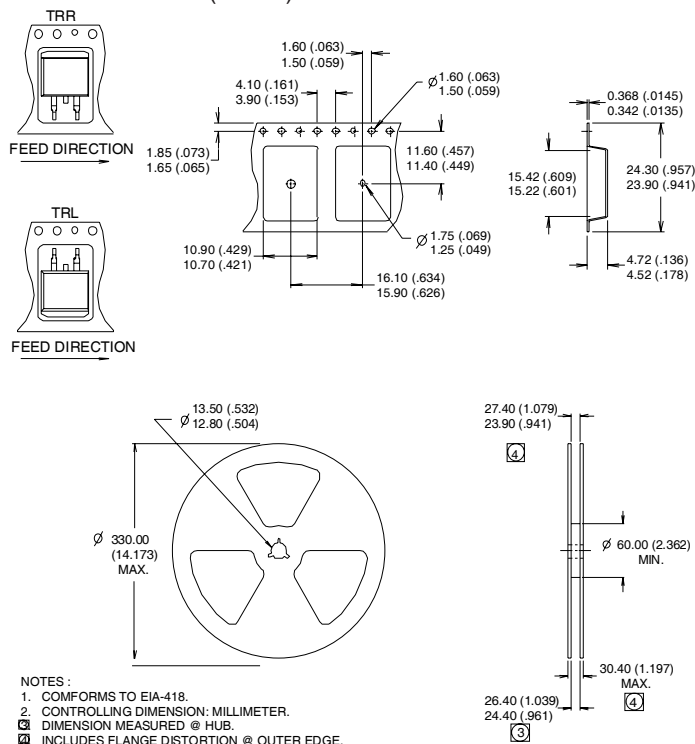
OR



Note: For the most current drawing please refer to IR website at <http://www.irf.com/package/>

D²Pak Tape & Reel Information

Dimensions are shown in millimeters (inches)



Notes:

- ① Repetitive rating: $V_{GE}=20V$; pulse width limited by maximum junction temperature (figure 20).
- ② $V_{CC}=80\%(V_{CES})$, $V_{GE}=20V$, $L=10\mu H$, $R_G = 23\Omega$ (figure 19).
- ③ Pulse width $\leq 80\mu s$; duty factor $\leq 0.1\%$.
- ④ Pulse width $5.0\mu s$, single shot.
- ⑤ When mounted on 1" square PCB (FR-4 or G-10 Material).

Data and specifications subject to change without notice.

International
IR Rectifier

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